

SILICON N-CHANNEL DUAL GATE MOS-FET

Depletion type field-effect transistor in a plastic X-package with source and substrate interconnected, intended for use in u.h.f. applications in television tuners and professional communication equipment.

This MOS-FET tetrode is protected against excessive input voltage surges by integrated back-to-back diodes between gates and source.

QUICK REFERENCE DATA

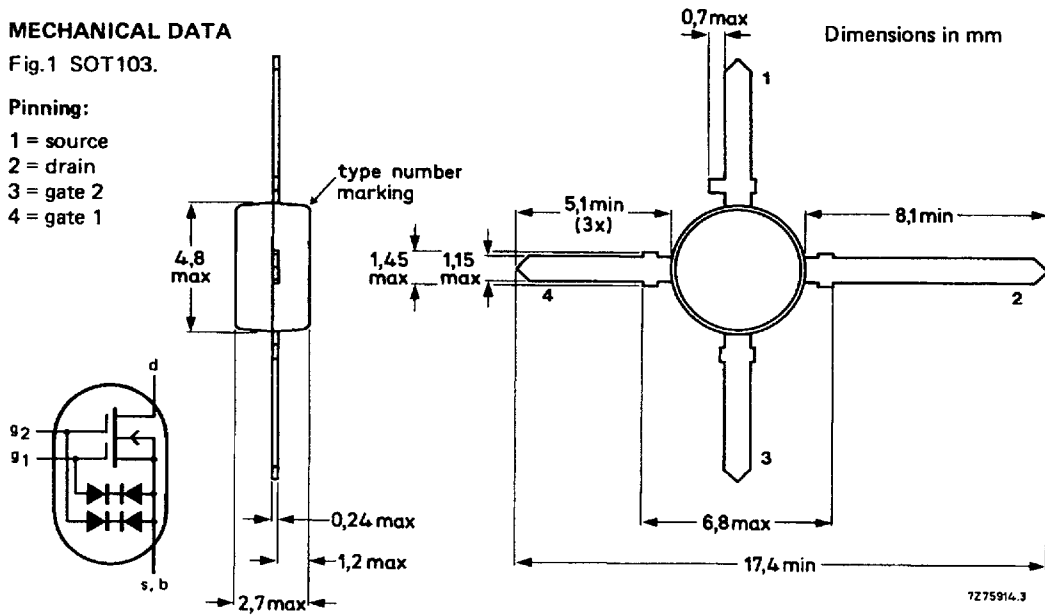
Drain-source voltage	V_{DS}	max.	20 V
Drain current	I_D	max.	20 mA
Total power dissipation up to $T_{amb} = 75^\circ\text{C}$	P_{tot}	max.	225 mW
Junction temperature	T_j	max.	150 $^\circ\text{C}$
Transfer admittance at $f = 1\text{ kHz}$ $I_D = 7\text{ mA}$; $V_{DS} = 10\text{ V}$; $+V_{G2-S} = 4\text{ V}$	$ y_{fs} $	typ.	12 mS
Input capacitance at gate 1; $f = 1\text{ MHz}$ $I_D = 7\text{ mA}$; $V_{DS} = 10\text{ V}$; $+V_{G2-S} = 4\text{ V}$	C_{ig1-s}	typ.	1.8 pF
Feedback capacitance at $f = 1\text{ MHz}$ $I_D = 7\text{ mA}$; $V_{DS} = 10\text{ V}$; $+V_{G2-S} = 4\text{ V}$	C_{rs}	typ.	25 fF
Noise figure at $G_S = 2\text{ mS}$; $B_S = B_S\text{ opt}$ $I_D = 7\text{ mA}$; $V_{DS} = 10\text{ V}$; $+V_{G2-S} = 4\text{ V}$; $f = 800\text{ MHz}$	F	typ.	2.8 dB

MECHANICAL DATA

Fig.1 SOT103.

Pinning:

- 1 = source
- 2 = drain
- 3 = gate 2
- 4 = gate 1



RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

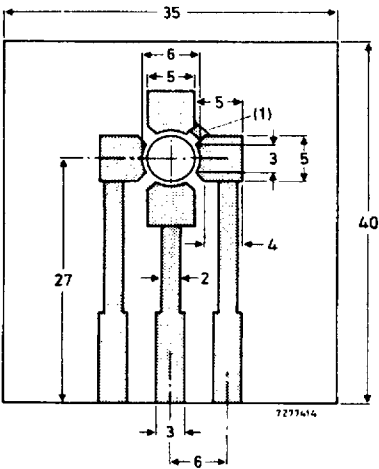
Drain-source voltage	V_{DS}	max.	20 V
Drain current (DC or average)	I_D	max.	20 mA
Gate 1 - source current	$\pm I_{G1-S}$	max.	10 mA
Gate 2 - source current	$\pm I_{G2-S}$	max.	10 mA
Total power dissipation up to $T_{amb} = 75\text{ }^{\circ}\text{C}$	P_{tot}	max.	225 mW
Storage temperature range	T_{stg}		$-65\text{ to }+150\text{ }^{\circ}\text{C}$
Junction temperature	T_j	max.	$150\text{ }^{\circ}\text{C}$

THERMAL RESISTANCE

From junction to ambient in free air
mounted on the printed-circuit board

$R_{th\ j-a} = 335\text{ K/W}$

Dimensions in mm



(1) Connection made by
a strip or Cu wire.

Fig.2 Single-sided 35 μm Cu-clad epoxy fibre-glass printed-circuit board, thickness 1.5 mm.
Tracks are fully tin-lead plated. Board in horizontal position for R_{th} measurement.

STATIC CHARACTERISTICS

 $T_j = 25\text{ }^{\circ}\text{C}$ unless otherwise specified

Gate cut-off currents

 $\pm V_{G1-S} = 5\text{ V}; V_{G2-S} = V_{DS} = 0$ $\pm I_{G1-SS}$ max. 25 nA $\pm V_{G2-S} = 5\text{ V}; V_{G1-S} = V_{DS} = 0$ $\pm I_{G2-SS}$ max. 25 nA

Gate-source breakdown voltages

 $\pm I_{G1-SS} = 10\text{ mA}; V_{G2-S} = V_{DS} = 0$ $\pm V_{(BR)G1-SS}$ 6 to 20 V $\pm I_{G2-SS} = 10\text{ mA}; V_{G1-S} = V_{DS} = 0$ $\pm V_{(BR)G2-SS}$ 6 to 20 V

Drain current

 $V_{DS} = 10\text{ V}; V_{G1-S} = 0; +V_{G2-S} = 4\text{ V}$ I_{DSS} 2 to 20 mA

Gate-source cut-off voltages

 $I_D = 20\text{ }\mu\text{A}; V_{DS} = 10\text{ V}; +V_{G2-S} = 4\text{ V}$ $-V_{(P)G1-S}$ max. 2.7 V $I_D = 20\text{ }\mu\text{A}; V_{DS} = 10\text{ V}; V_{G1-S} = 0$ $-V_{(P)G2-S}$ max. 2.7 V

DYNAMIC CHARACTERISTICS

Measuring conditions (common source): $I_D = 7\text{ mA}; V_{DS} = 10\text{ V}; +V_{G2-S} = 4\text{ V}; T_{amb} = 25\text{ }^{\circ}\text{C}$ Transfer admittance at $f = 1\text{ kHz}$ $|Y_{fs}|$ min. 9.5 mS

typ. 12 mS

Input capacitance at gate 1; $f = 1\text{ MHz}$ C_{ig1-s} typ. 1.8 pFInput capacitance at gate 2; $f = 1\text{ MHz}$ C_{ig2-s} typ. 1.0 pFFeedback capacitance at $f = 1\text{ MHz}$ C_{rs} typ. 25 fFOutput capacitance at $f = 1\text{ MHz}$ C_{os} typ. 0.9 pFNoise figure at $G_S = 2\text{ mS}; B_S = B_S\text{ opt}$ $f = 200\text{ MHz}$ F typ. 1.6 dB $f = 800\text{ MHz}$ F typ. 2.8 dBPower gain at $G_S = 2\text{ mS}; B_S = B_S\text{ opt}$ $G_L = 0.5\text{ mS}; B_L = B_L\text{ opt}; f = 200\text{ MHz}$ G_p typ. 23 dB $G_L = 1\text{ mS}; B_L = B_L\text{ opt}; f = 800\text{ MHz}$ G_p typ. 16.5 dB